# UP04112

### Silicon PNP epitaxial planar type

For digital circuits

#### Features

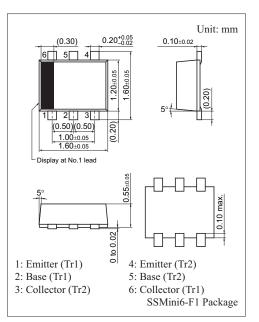
- Two elements incorporated into one package (Transistors with built-in resistor)
- SSMini type package, reduction of the mounting area and assembly cost

#### Basic Part Number

• UNR2112 × 2

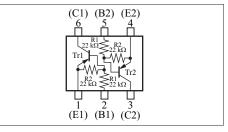
#### Absolute Maximum Ratings $T_a = 25^{\circ}C$

Parameter	Symbol	Rating	Unit
Collector-base voltage (Emitter open)	V <sub>CBO</sub>	-50	V
Collector-emitter voltage (Base open)	V <sub>CEO</sub>	-50	V
Collector current	I <sub>C</sub>	-100	mA
Total power dissipation	P <sub>T</sub>	125	mW
Junction temperature	Tj	125	°C
Storage temperature	T <sub>stg</sub>	-55 to +125	°C



#### Marking Symbol: 6R

#### Internal Connection



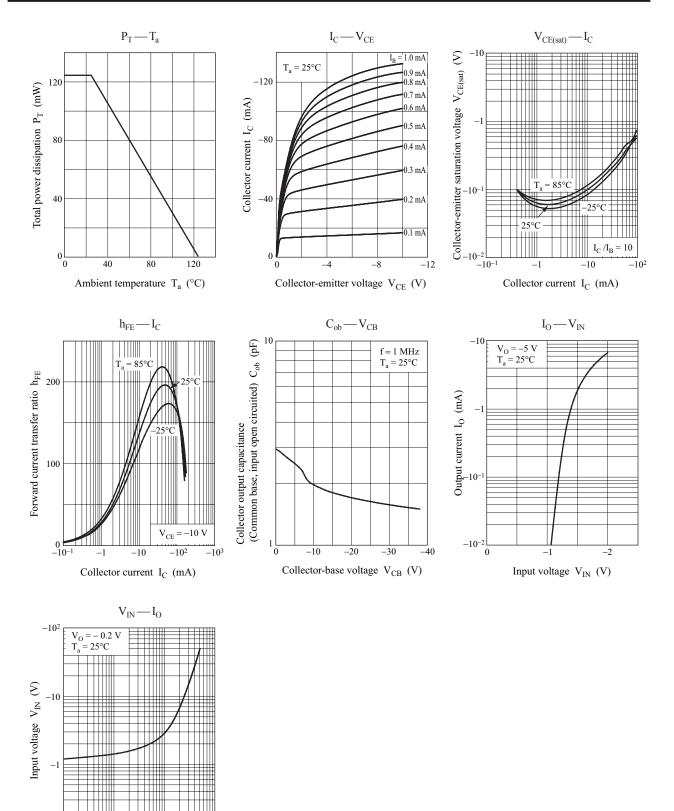
#### Conditions Parameter Symbol Max Unit Min Тур -50 V Collector-base voltage (Emitter open) $V_{CBO}$ $I_{\rm C} = -10 \ \mu A, I_{\rm E} = 0$ -50V Collector-emitter voltage (Base open) $I_{C} = -2 \text{ mA}, I_{B} = 0$ V<sub>CEO</sub> $V_{CB} = -50 \text{ V}, I_E = 0$ Collector-base cutoff current (Emitter open) -0.1μΑ I<sub>CBO</sub> $V_{CE} = -50 \text{ V}, I_B = 0$ -0.5Collector-emitter cutoff current (Base open) I<sub>CEO</sub> μΑ $V_{EB} = -6 V, I_C = 0$ Emitter-base cutoff current (Collector open) -0.2 $I_{\text{EBO}}$ mA Forward current transfer ratio $V_{CE} = -10 \text{ V}, I_C = -5 \text{ mA}$ 60 h<sub>FE</sub> Collector-emitter saturation voltage V<sub>CE(sat)</sub> $I_{\rm C} = -10 \text{ mA}, I_{\rm B} = -0.3 \text{ mA}$ -0.25V Output voltage high-level $V_{CC} = -5 \text{ V}, V_B = -0.5 \text{ V}, R_L = 1 \text{ k}\Omega$ -4.9 V VOH $V_{CC} = -5 \text{ V}, V_B = -2.5 \text{ V}, R_L = 1 \text{ k}\Omega$ -0.2V Output voltage low-level VOL $R_1$ -30% +30%Input resistance 22 kΩ 1.2 Resistance ratio $R_1 / R_2$ 0.8 1.0 80 MHz Transition frequency $f_T$ $V_{CB} = -10 \text{ V}, I_E = 1 \text{ mA}, f = 200 \text{ MHz}$

#### Electrical Characteristics $T_a = 25^{\circ}C \pm 3^{\circ}C$

Note) Measuring methods are based on JAPANESE INDUSTRIAL STANDARD JIS C 7030 measuring methods for transistors.

### UP04112

### **Panasonic**



-10

-1

 $-10^{2}$ 

2

 $-10^{-1}$   $\_$   $-10^{-1}$ 

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